Outlier Analysis Using Frequent Pattern Mining (LOF Algorithm)

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Abstract - An outlier in a dataset is an observation or a point that is considerably dissimilar to or inconsistent with the remainder of the data. Detection of such outliers is important for many applications and has recently attracted much attention in the data mining research community. In this paper, we present a new method to detect outliers by discovering frequent patterns (or frequent item sets) from the data set. The outliers are defined as the data transactions that contain less frequent patterns in their item sets. We define a measure called FPOF (Frequent Pattern Outlier Factor) to detect the outlier transactions and propose the Find FPOF algorithm to discover outliers. The experimental results have shown that our approach outperformed the existing methods on identifying interesting outliers.

Keywords - Frequent pattern mining, Association rules, Data mining research, Applications, FPOF, abnormalities, discordant, deviants, anomalies.

I. INTRODUCTION

An outlier is a data point which is significantly different from the remaining data. Hawkins formally defined [20] the concept of an outlier as follows: “An outlier is an observation which deviates so much from the other observations as to arouse suspicions that it was generated by a different mechanism.” Outliers are also referred to as abnormalities, discordant, deviants, or anomalies in the data mining and statistics literature. In most applications, the data is created by one or more generating processes, which could either reflect activity in the system or observations collected about entities. When the generating process behaves in an unusual way, it results in the creation of outliers. Therefore, an outlier often contains useful information about abnormal characteristics of the systems and entities, which impact the data generation process. The recognition of such unusual characteristics provides useful application-specific insights.

The output of an outlier detection algorithm can be one of two types

Most outlier detection algorithm output a score about the level of “outlierness” of a data point. This can be used in order to determine a ranking of the data points in terms of their outlier tendency. This is a very general form of output, which retains all the information provided by a particular algorithm, but does not provide a concise summary of the small number of data points which should be considered outliers. A second kind of output is a binary label indicating whether a data point is an outlier or not. While some algorithms may directly return binary labels, the outlier scores can also be converted into binary labels. This is typically done by imposing thresholds on outlier scores, based on their statistical distribution. A binary labeling contains less information than a scoring mechanism, but it is the final result which is often needed for decision making in practical applications.

II. RELATED WORK AND RESEARCH MOTIVATION

Local Outlier Factor (LOF) [Breunig et al. 1999], [Breunig et al. 2000]
Motivation - Distance-based outlier detection models have problems with different densities
How to compare the neighborhood of points from areas of different densities? Example- DB(ε,π)-outlier model
Parameters $\varepsilon$ and $\pi$ cannot be chosen so that $o_2$ is an outlier but none of the points in cluster $C_1$ (e.g. $q$) is an outlier

- Outliers based on kNN-distance

kNN-distances of objects in $C_1$ e.g. $q$) are larger than the kNN-distance of $o_2$

Solution: consider

- relative density

Reachability distance

- Introduces a smoothing factor

reach dist $(p, o) = \max\{k \text{distance}(o), \text{dist}(p, o)\}$

Local reachability distance (lrd) of point $p$

- Inverse of the average reach-dists of the $k$NNs of $p$

$$lrd_k(p) = \{\frac{\sum \text{reach-dist}_k(p, o)}{\text{Card}(kNN(p))}\}$$

- Local outlier factor (LOF) of point $p$

- Average ratio of lrd of neighbors of $p$ and lrd of $p$

$$LOF_k(p) = \frac{\sum \frac{lrd_k(o)}{\text{Card}(kNN(o))}}{\text{Card}(kNN(p))}$$
The outlier detection problem itself is not well defined and none of the existing definitions are widely accepted. Although several techniques have been proved useful in solving some outlier detection problems, the following problems still remain to be further explored and motivate our research.

**Firstly**, the existing techniques try to detect outliers using the distance of points in the full dimensional space. Recent research results show that in the high dimensional space, the concept of proximity may not be qualitatively meaningful [17]. Due to the curse of dimensionality, these approaches are not appropriate for discovering outliers in a high dimensional space. Furthermore, they failed to find outliers in the subsets of dimensions. The method proposed by Aggarwal and Yu [4] considers data points in a local region of abnormally low density as outliers to conquer the curse of dimensionality. The main problem of their approach is that the outlier factor of each data object is determined only by the projection with the lowest density of data, without considering the effect of other projections. Moreover, their algorithm has a high computational cost. Wei et al. [7] introduced an outlier mining method based on a hyper-graph model to detect outliers from a categorical dataset. In that method, since all data points are constructed as the vertices of a hyper-graph, again it is computationally intensive.

**Secondly**, most studies on outlier detection are focused only on identifying outliers. In real applications, the reasons on why the identified outliers are abnormal also need to be given. Such descriptions should be intuitive and provide the user with some hints for further actions. Knorr and Ng [18] discussed the concept of intentional knowledge of distance-based outliers in terms of the subset of attributes. Their algorithms traverse all the sub-dimensions to find distance-based outliers and then the intentional knowledge. This search approach is intensive in computation and cannot provide an overall interpretability for different subspaces in reasoning which causes the abnormality.

### Outlier Method Comparison

<table>
<thead>
<tr>
<th>Issues</th>
<th>Outlier Analysis Using FP Approach</th>
<th>Term Based Approach</th>
<th>Phrase Based Approach</th>
<th>Emerging Pattern Approach</th>
</tr>
</thead>
<tbody>
<tr>
<td>polysemy</td>
<td>Not found</td>
<td>Found</td>
<td>Found</td>
<td>Partially found</td>
</tr>
<tr>
<td>synonymy</td>
<td>Not found</td>
<td>Found</td>
<td>Found</td>
<td>Partially found</td>
</tr>
<tr>
<td>Info. filtering</td>
<td>Easy</td>
<td>Complex</td>
<td>Complex</td>
<td>Complex</td>
</tr>
<tr>
<td>Object noise</td>
<td>Very less</td>
<td>Less</td>
<td>Medium</td>
<td>More</td>
</tr>
<tr>
<td>Noise handling</td>
<td>Complex</td>
<td>Easy</td>
<td>Easy</td>
<td>Complex</td>
</tr>
<tr>
<td>PDS</td>
<td>Post processing required</td>
<td>Not required</td>
<td>Feature extraction</td>
<td>Concatenation required</td>
</tr>
<tr>
<td>Ambiguity</td>
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<td>Less</td>
<td>More</td>
<td>More</td>
</tr>
<tr>
<td>Obj. divergence</td>
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<td>n/a</td>
<td>n/a</td>
</tr>
</tbody>
</table>

### III. PROPOSED SOLUTION

**Meta-Algorithms for Outlier Analysis**

In many data mining problems such as clustering and classification, a variety of meta-algorithms are used in order to improve the robustness of the underlying solutions. For example, in the case of the classification problem, a variety of ensemble methods such as bagging, boosting and stacking are used in order to improve the robustness of the classification [146]. Similarly, in the case of clustering, ensemble methods are often used in order to improve the quality of the clustering [20]. Therefore, it is natural to ask whether such meta-algorithms also exist for the outlier detection problem. The answer is in the affirmative, though the work on meta-algorithms for outlier detection is often quite scattered in the literature, and in comparison to other problems such as classification, not as well formalized. In some cases such as sequential ensembles, the corresponding techniques are often repeatedly used in the context of specific techniques.

The different meta-algorithms for outlier detection will be discussed in the following subsections. There are two primary kinds of ensembles, which can be used in order to improve the quality of outlier detection algorithms: In **sequential ensembles**, a given algorithm or set of algorithms are applied sequentially, so that future applications of the algorithms are impacted by previous applications, in terms of either modifications of the base data for analysis or in terms of the specific choices of the algorithms. The final result is either a weighted combination of, or the final result of the last application of an outlier analysis algorithm. For example, in the context of the classification problem, boosting methods may be considered examples of sequential ensembles.

In **independent ensembles**, different algorithms, or different instantiations of the same algorithm are applied to either the complete data or portions of the data. The choices made about the data and algorithms applied are independent of the results obtained from these different algorithmic executions. The results from the different algorithm executions are combined together in order to obtain more robust outliers.

**Algorithm** SequentialEnsemble(Data Set: D)

**Base Algorithms:** A1 . . . Ar)

**begin**

j = 1;

**repeat**
Pick an algorithm $A_j$ based on results from past executions;  
Create a new data set $f_j(D)$ from $D$ based on results from past executions;  
Apply $A_j$ to $D_j$;  
$j = j + 1$;  
until (termination);  
report outliers based on combinations of results from previous executions;  
end

### IV. EXPERIMENTAL RESULTS

**The Density Based LOF algorithm**

LOF (Local Outlier Factor) is an algorithm for identifying density-based local outliers [Breunig et al., 2000]. With LOF, the local density of a point is compared with that of its neighbors. If the former is significantly lower than the latter (with an LOF value greater than one), the point is in a sparser region than its neighbors, which suggests it be an outlier.

Function lofactor(data, k) in packages DMwR and dprep calculates local outlier factors using the LOF algorithm, where k is the number of neighbors used in the calculation of the local outlier factors.

![density.default(x = outlier.scores)](image)

```r
> # pick top 5 as outliers
> outliers <- order(outlier.scores, decreasing=T)[1:5]
> # who are outliers
> print(outliers)
[1] 42 107 23 110 63
> print(iris2[outliers,])

<table>
<thead>
<tr>
<th></th>
<th>Sepal.Length</th>
<th>Sepal.Width</th>
<th>Petal.Length</th>
<th>Petal.Width</th>
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<tr>
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<td>4.5</td>
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<tr>
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<td>1.0</td>
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<tr>
<td>110</td>
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<td>3.6</td>
<td>6.1</td>
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<tr>
<td>63</td>
<td>6.0</td>
<td>2.2</td>
<td>4.0</td>
<td>1.0</td>
</tr>
</tbody>
</table>
```

**Visualize Outliers with Plots**

Next, we show outliers with a biplot of the first two principal components

```r
> n <- nrow(iris2)
> labels <- 1:n
> labels[-outliers] < - ""
> biplot(prcomp(iris2), cex=.8, xlabs=labels)
```
We can also show outliers with a pairs plot as below, where outliers are labeled with “+” in red.

V. CONCLUSIONS AND FUTURE WORK

Frequent pattern mining and outlier detection are two integral parts of data mining and have attracted attentions in their own fields. Based on frequent patterns, this paper has proposed a new outlier detection method. The effectiveness of the method was verified by the experimental results. Using the same process and functionality to solve both frequent pattern mining and outlier discovery is highly desirable. Such integration will be a great benefit to business users because they do not need to worry about the selection of different data mining algorithms. Instead, they can focus on data and business solution. More importantly, some commercial data mining software do not provide the functionality of outlier discovery, hence it is easier to discover outliers directly using the frequent pattern mining results (since most commercial data mining software provide association mining module). Several questions remain open and will be addressed in our future work: Firstly, how to automatically assign a proper value to the parameter of minisupport shall be investigated. Secondly, the number of frequent itemsets is usually huge, therefore, a number of lossless representations of frequent itemsets have recently been proposed. Two of such representations, namely the closed itemsets [26] and the generators representation [27], are of particular interest. Hence, we are planning to use these alternative representations of frequent itemsets to improve the performance of the FindFPOF algorithm. Finally and more importantly, it is well recognized that true correlation relationships among data objects may be missed in the support-based association-mining framework. To overcome this difficulty, correlation has been adopted as an interesting measure since most people are interested in not only association-like co-occurrences but also the possible strong correlations implied by such co-occurrences. Therefore, statistical correlation based outlier detection will be another promising research direction.
VI. ACKNOWLEDGEMENT
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